

<b>Notice of References Cited</b>	Application/Control No. 10/015,458	Applicant(s)/Patent Under Reexamination ORTIZ ET AL.	
	Examiner Chriss S. Yoder, III	Art Unit 2612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,405,371 B1	06-2002	Oosterhout et al.	725/39
	B	US-2003/0041334 A1	02-2003	Lu, Jin	725/113
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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